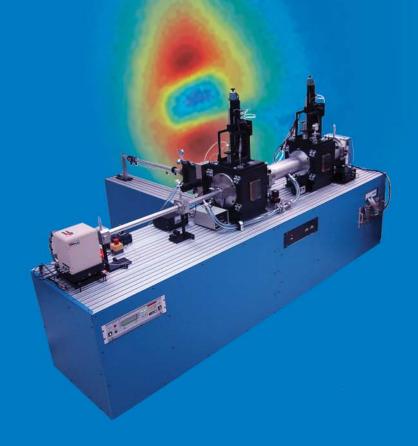


S-Max3000

Pinhole SAXS Camera Small angle X-ray scattering solutions







Our small angle X-ray scar you the greatest flexibility

Our instruments feature:

- User variable scattering resolution/range
- Highest flux in a lab system
- Larger multiwire detector area for increased scattering range

Sample changer

Simultaneous WAXS/SAXS Load/lock mechanism for WAXS imaging plate

Continuous vacuum from source to detector

All positioning performed outside the vacuum and radiation area

High-brilliance, low-maintenance source (MicroMax[™]-002+)

> Stable base (12' x 3' footprint, main beamline)



ttering tools give y, flux and precision

Options:

- Simultaneous SAXS/WAXS
- Sample environmental control
- Solution scattering

Additional sample chamber for mid-range SAXS Photodiode embedded 2D detector beamstop for continuous (gas-filled multiwire type) intensity monitoring Large sample chamber adaptable for in-situ measurements

User replaceable beamstop



System specifications

Sources:	MicroMax-007 HF or MicroMax-002+
Optic:	Osmic Confocal Max-Flux® for SAXS
Pinholes:	3 pinholes Pinhole size adjusted by exchanging pinholes Position adjustable
Sample:	2D linear motion for alignment and sample exchange A wide range of samples can be incorporated
Beamstop:	PIN diode loaded beam stop for online beam monitoring Beamstop size adjusted by exchanging pinhole
Detector:	2D multiwire detector 120 mm diameter Resolution: 512 x 512 to 4096 x 4096
Detection hardware:	NIM-based electronics with Fastec MCA with time-stamping feature for pump probe measurements
Software:	Instrument control: LabVIEW® (Windows®) Online data-recording: Fastec Imaging™ viewing software Data-reduction: MATLAB® based program
System resolution:	SAXS: 100 nm < d-spacing < 3.8 nm
Vacuum:	Diaphragm pump
System:	All components integrated on a bench
Options:	 System can be configured to allow easy access to data in the wide (WAXS) and medium (MAXS) angular range Manual interchangeable pinholes can be replaced by automated pinhole replacement (by JJ X-ray) Sample area can accommodate almost any kind of sample environment 200 mm diameter detector can be chosen to accommodate larger q-range

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